

<b>Notice of References Cited</b>	Application/Control No. 10/035,315	Applicant(s)/Patent Under Reexamination TENG, WEI KUANG	
	Examiner Eleni A. Shiferaw	Art Unit 2136	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0015652 A1	01-2005	Han et al.	714/006
	B	US-			
	C	US-			
	D	US-			
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**FOREIGN PATENT DOCUMENTS**

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